



## **Description**

The XPX009N04TD uses advanced trench technology and design to provide excellent  $R_{\text{DS(ON)}}$  with low gate charge. It can be used in a wide variety of applications.

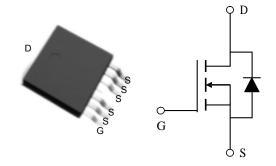
### **General Features**

- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E<sub>AS</sub>
- Excellent package for good heat dissipation

### **Application**

- PWM
- Load Switching

 $V_{DS} = 40V, I_{D} = 320A$   $R_{DS}(ON) = 0.9 m\Omega$  (typ) @  $V_{GS} = 10V$   $R_{DS}(ON) = 1.3 m\Omega$  (typ) @  $V_{GS} = 4.5V$ 



### **Package Marking and Ordering Information**

Device	Pack	Marking	Qty(PCS)
XPX009N04TD	TO-263-7	XXXXX YYYY	2000

### Absolute Maximum Ratings (T<sub>A</sub>=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	40	V
Gate-Source Voltage	V <sub>G</sub> s	±20	V
Drain Current-Continuous	I <sub>D</sub>	320	Α
Drain Current-Continuous(T <sub>C</sub> =100°C)	I <sub>D</sub> (100℃)	226	Α
Pulsed Drain Current <sup>(Note 1)</sup>	I <sub>DM</sub>	1280	Α
Maximum Power Dissipation	P <sub>D</sub>	400	W
Derating factor		2.67	W/℃
Single pulse avalanche energy (Note 5)	E <sub>AS</sub>	2500	mJ
Operating Junction and Storage Temperature Range	$T_{J}, T_{STG}$	-55 To 175	$^{\circ}$ C
Thermal Resistance,Junction-to-Case <sup>(Note 2)</sup>	R <sub>eJC</sub>	0.38	°C/W



## Electrical Characteristics (T<sub>A</sub>=25 ℃ unless otherwise noted)

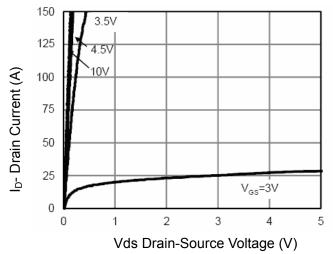
Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	40		-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =40V,V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)			•			
Gate Threshold Voltage	$V_{GS(th)}$	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA	2	3	4	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =160A	-	0.9	1.3	mΩ
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =5V,I <sub>D</sub> =160A	-	100	-	S
Dynamic Characteristics (Note4)			•			
Input Capacitance	C <sub>lss</sub>	\/ Q5\/\/ Q\/	-	11998	-	PF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> =25V,V <sub>GS</sub> =0V, F=1.0MHz	-	1560	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>	F=1.0IVID2	-	1324	-	PF
Switching Characteristics (Note 4)			•			
Turn-on Delay Time	t <sub>d(on)</sub>		-	42	-	nS
Turn-on Rise Time	t <sub>r</sub>	$V_{DD}$ =20 $V$ , $R_L$ =15 $\Omega$ ,	-	41	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_G$ =2.5 $\Omega$ , $V_{GS}$ =10 $V$	-	150	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	70	-	nS
Total Gate Charge	Qg		-	249	-	nC
Gate-Source Charge	$Q_{gs}$	I <sub>D</sub> =160A,V <sub>DD</sub> =20V,V <sub>GS</sub> =10V	-	40	-	nC
Gate-Drain Charge	$Q_{gd}$		-	80	-	nC
Drain-Source Diode Characteristics			•			
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =160A	-	1.0	2.0	V
Diode Forward Current (Note 2)	Is		-	-	320	Α
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25°C, I <sub>F</sub> = 160A	-	55		nS
Reverse Recovery Charge	Qrr	di/dt = 100A/µs <sup>(Note3)</sup>	-	180		nC

### Notes:

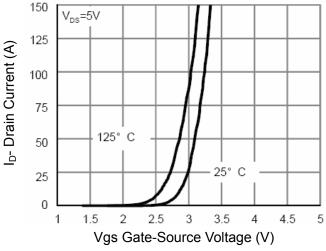
- $\textbf{1.} \ \textbf{Repetitive Rating: Pulse width limited by maximum junction temperature.}$
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width  $\leq$  300 $\mu$ s, Duty Cycle  $\leq$  2%.
- **4.** Guaranteed by design, not subject to production
- 5. EAS condition: Tj=25  $^{\circ}\text{C}\text{,V}_{DD}\text{=}20\text{V,V}_{G}\text{=}10\text{V,L=}0.5\text{mH,Rg=}25\Omega$



### Typical Electrical and Thermal Characteristics (Curves)



**Figure 1 Output Characteristics** 



**Figure 2 Transfer Characteristics** 

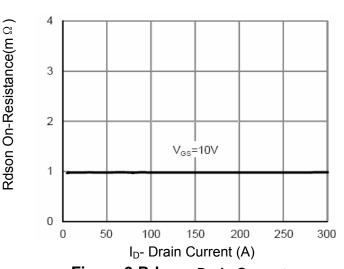


Figure 3 Rdson- Drain Current

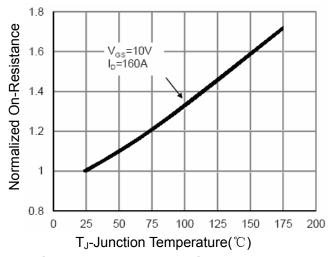
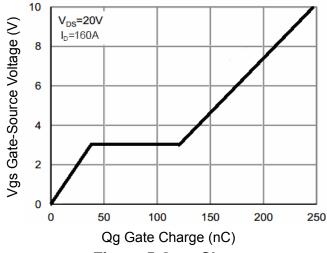


Figure 4 Rdson-JunctionTemperature



**Figure 5 Gate Charge** 

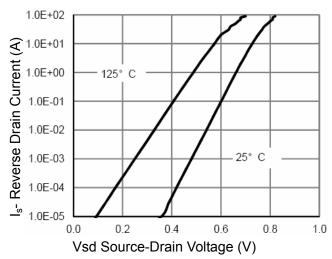
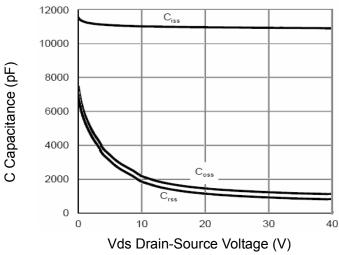


Figure 6 Source- Drain Diode Forward

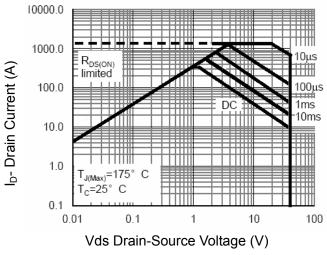


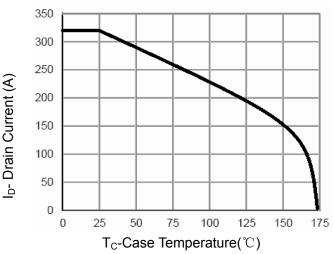


400 Power Dissipation (W) 350 300 250 200 150 100 50 0 25 125 75 100 150 175  $T_C$ -Case Temperature( $^{\circ}C$ )

Figure 7 Capacitance vs Vds

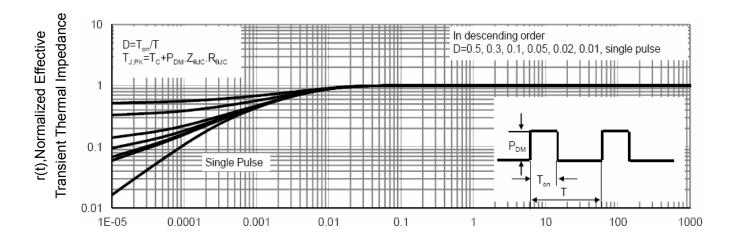






**Figure 8 Safe Operation Area** 

Figure 10 Current De-rating



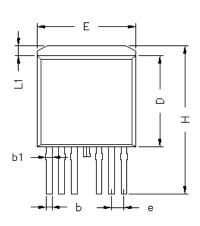
Square Wave Pluse Duration (sec)

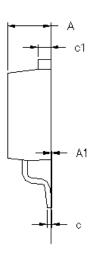
Figure 11 Normalized Maximum Transient Thermal Impedance

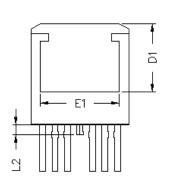


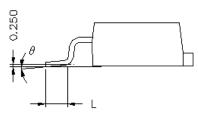
# Package Information

TO-263-7



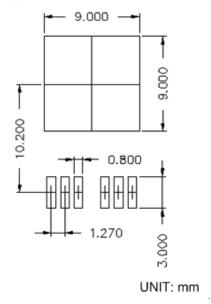






		TO-263· 7			
SYMBOLS	MILLIN	IETERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
Α	4.25	4.55	0.167	0.179	
A1	0.01	0.25	0.000	0.010	
b	0.50	0.70	0.020	0.028	
b1	0.60	0.84	0.024	0.033	
С	0.40	0.60	0.016	0.024	
c1	1.20	1.40	0.047	0.055	
D	9.05	9.45	0.356	0.372	
D1	6.90	9.00	0.272	0.354	
E	9.80	10.20	0.386	0.402	
E1	7.25	9.00	0.285	0.354	
е	1.27	BSC	0.05	BSC	
Н	14.65	15.35	0.577	0.604	
L	2.40	3.00	0.094	0.118	
L1	0.80	1.20	0.031	0.047	
L2	0.85	1.15	0.033	0.045	
$\theta$	2°	8°	2°	8°	

#### RECOMMENDED LAND PATTERN





#### Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time	
Pb device	245℃±5℃	5sec±1sec	
Pb-Free device	260℃+0/-5℃	5sec±1sec	



This integrated circuit can be damaged by ESD UniverChip Corporation recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedure can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

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